

<b>Notice of References Cited</b>	Application/Control No. 09/614,721	Applicant(s)/Patent Under Reexamination MATSUDA ET AL.	
	Examiner Cindy Nguyen	Art Unit 2161	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,035,338	03-2000	Hirakawa et al.	709/243
*	B	US-5,983,247	11-1999	Yamanaka et al.	715/526
*	C	US-6,073,143	06-2000	Nishikawa et al.	715/513
*	D	US-6,742,163	05-2004	Ono et al.	715/513
*	E	US-6,424,980	07-2002	Iizuka et al.	715/513
*	F	US-6,546,406	04-2003	DeRose et al.	715/513
*	G	US-6,594,697	07-2003	Praitis et al.	709/225
*	H	US-6,763,496	07-2004	Hennings et al.	715/501.1
*	I	US-5,628,008	05-1997	Hayashi, Shoichi	715/513
	J	US-5,953,718	09-1999	Wical, Kelly	707/5
*	K	US-6,460,034	10-2002	Wical, Kelly	707/5
	L	US-5,848,410	12-1998	Walls et al.	707/4
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.